Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination
10/043,276	NAKATANI ET AL.
Examiner	Art Unit
Junghwa M. Im	2811

SEARCHED				
Class	Subclass	Date	Examiner	
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARC (INCLUDING SE)
		DATE	EXMR
updated search		12/8/2006	JMI
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